# Effect of rapid thermal annealing in vacuum on the structural and optical properties of MoS<sub>2</sub> flakes in solution

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## Abstract

Recently, top-down and bottom-up methods have been developed to fabricate single-layer (1L) MoS<sub>2</sub> nanosheets. The top-down method focuses on the mechanical [1-2] and solution-based exfoliation [3-4] of bulk MoS<sub>2</sub> crystals. Although the mechanical exfoliation of MoS<sub>2</sub> can produce the pristine 1L MoS<sub>2</sub> with high quality, its yield and reproducibility are low. The solution-based exfoliated MoS<sub>2</sub> is often accompanied by residual chemicals from the solution used, which in turn affects the properties of MoS<sub>2</sub> nanosheets [3]. In the previous studies, a thermal annealing method has been used in layer thinning and etching of mechanically exfoliated MoS<sub>2</sub> for achieving single-layer MoS<sub>2</sub> from multi-layer MoS<sub>2</sub>[1]. In this work, MoS<sub>2</sub> flakes of ~ 400 nm lateral size in ethanol solution were used to investigate the thermal annealing mechanism of MoS<sub>2</sub> flakes. For single-layer MoS<sub>2</sub> nanosheets, MoS<sub>2</sub> flakes solution was dropped on the whole surface of 100 nm SiO<sub>2</sub> substrate and subsequently, MoS<sub>2</sub> flakes were heated by rapid thermal annealing at various temperatures from 100 to 500 °C under vacuum for 10 min. The annealed samples were characterized by optical microscopy, Raman spectroscopy, and atomic force microscopy (AFM). Fig. 1 shows the optical images of MoS<sub>2</sub> nanosheets on 100 nm SiO<sub>2</sub> /Si, in which different color contrast represents different layer thickness of MoS<sub>2</sub>. [5] Fig. 1 (a) shows the MoS<sub>2</sub> flakes before thermal annealing, which consists mainly of 6L nanosheets. Subsequently, thermal annealing was performed at 200 °C for 10 min. The formation of 2L MoS<sub>2</sub> nanosheet by thinning was observed after thermal annealing, as shown in Fig 1 (b). Raman spectra of the transferred layers exhibited two intense features,  $E_{2g}^{1}$  and  $A_{1g}$  peaks at ~ 384 and ~ 403 cm<sup>-1</sup>, respectively, uniquely characteristic of MoS<sub>2</sub> film. The two Raman modes, E<sup>1</sup><sub>2g</sub> and A<sub>1g</sub>, exhibited sensitive thickness dependences, with the frequency of the former decreasing and that of the latter increasing with thickness [6]. The annealing behaviors show several intriguing characteristics. Most strikingly, we find that the E<sup>1</sup><sub>2g</sub> vibration softens (blue shifts), while the A<sub>1g</sub> vibration stiffens (red shifts) with increasing annealing temperature, as shown in Fig 2. This Raman analysis reveals optimum annealing temperature of 200 °C for the synthesis of smallest-layer-number and best-quality MoS<sub>2</sub>. The thickness of MoS<sub>2</sub> estimated by AFM was consistent with the Raman results. As a result of thermal annealing, the MoS<sub>2</sub> nanosheet is thinned, possibly due to its oxidation to form MoO<sub>3</sub>. Possible mechanisms are proposed to explain the formation processes of MoS<sub>2</sub> nanosheets from MoS<sub>2</sub> flakes during the annealing.

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## Figures



Fig. 1. Optical images of  $MoS_2$  flacks before (a) and after (b) thermal annealing in vacuum for 10 min at 200 ° C



Fig. 2. Raman spectra of  $MoS_2$  flakes for various annealing temperatures together with the spectrum before thermal annealing